

**Search Notes**

Application/Control No.

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Examiner

Phu Vu

Applicant(s)/Patent under  
Reexamination

YANO ET AL.

Art Unit

2871

**SEARCHED**

Class	Subclass	Date	Examiner
349	118	4/10/2005	PV

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Fast Search see printout US Pat ; PG PUB	7/18/05	P.V.